

Supporting Information

Influence of Mo doping on interfacial charge carrier dynamics in photoelectrochemical water oxidation on BiVO₄

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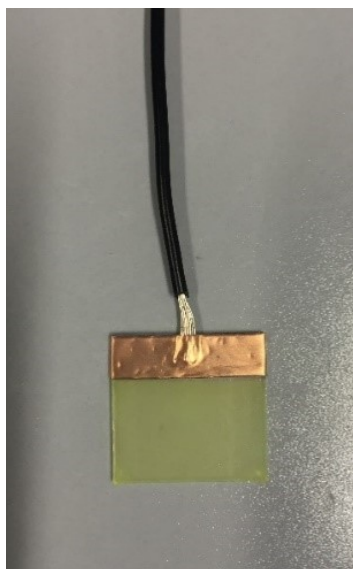


Figure S1 Contacting of BVO photoelectrode.

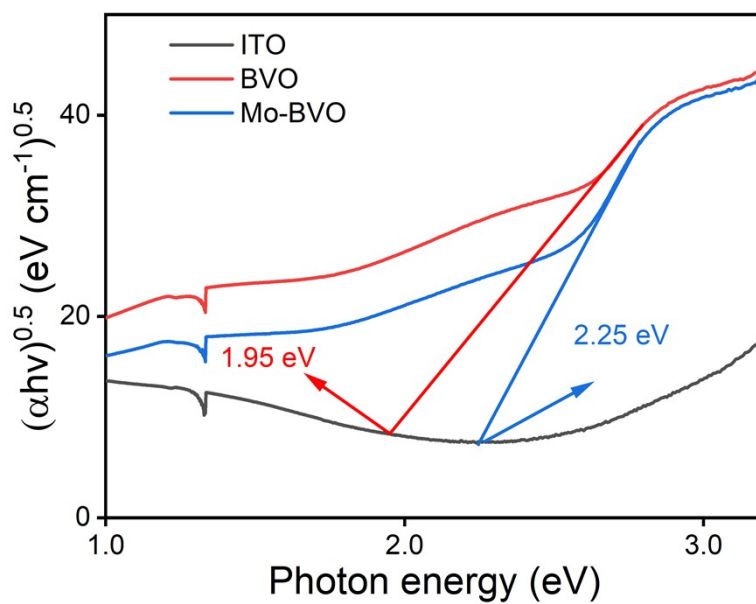


Figure S2 Tauc plots of as-prepared BiVO_4 film samples, assuming indirect optical absorption.

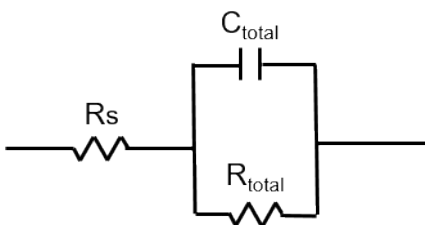


Figure S3 Randles model for fitting electrochemical impedance spectra of as-prepared samples.

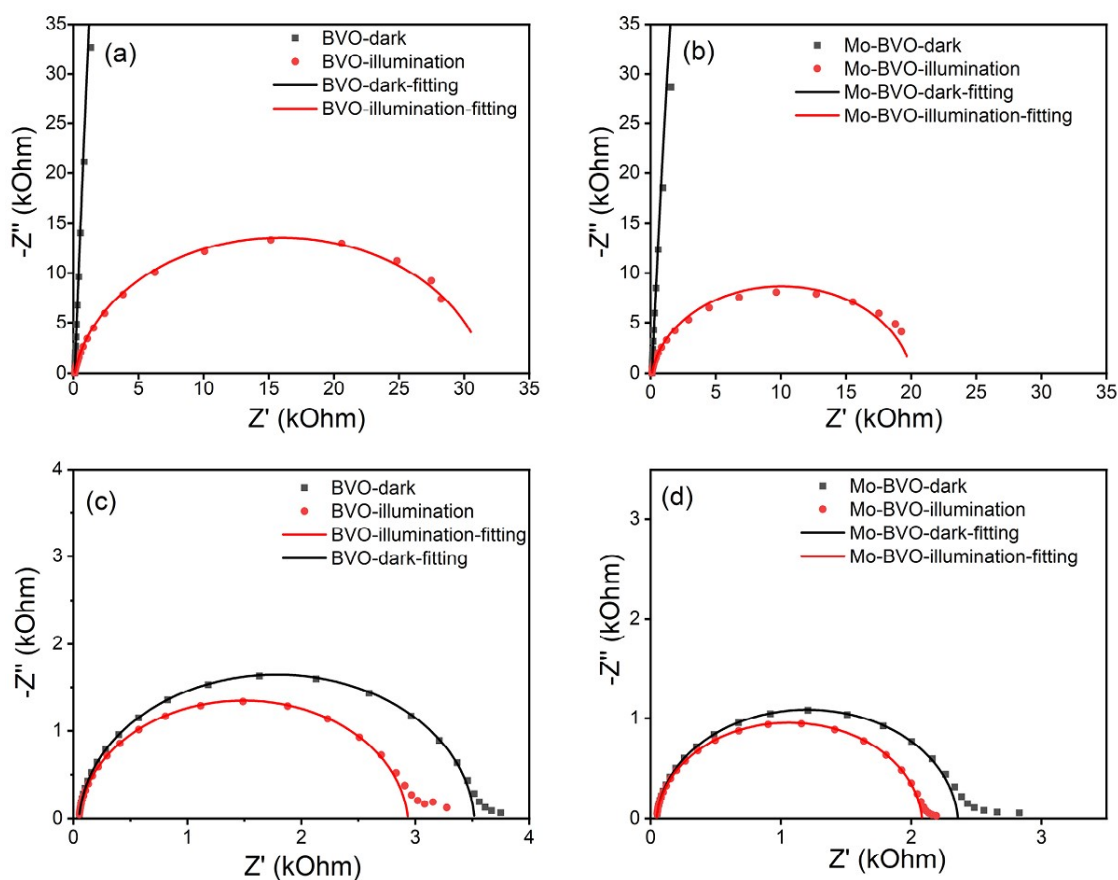


Figure S4 EIS fitting results of as-prepared samples, measured at 1.2 V vs. RHE in 0.1 M phosphate buffer solution ((a) and (b)) and 0.5 M Na_2SO_3 solution ((c) and (d)).

Table S1 Element parameters of Randles equivalent circuit, obtained from EIS data fitting, measured in 0.1 M phosphate buffer solution

| Sample | Condition | Rs (Ω) | CPE | | R _{total} =R _{bulk} +R _{ct} (M Ω) | Error(%) |
|--------|--------------|-----------------|-------------------------------|----------|---|----------|
| | | | C _{total} (μ F) | α | | |
| BVO | Dark | 101 | 3.03 | 0.982 | 12.6 | 1.3 |
| | Illumination | 92.9 | 2.85 | 0.904 | 31.6 $\times 10^{-3}$ | 6.9 |
| Mo-BVO | Dark | 99.7 | 3.40 | 0.979 | 5.51 | 2.7 |
| | Illumination | 91.9 | 3.06 | 0.911 | 19.9 $\times 10^{-3}$ | 14.1 |

Table S2 Element parameters of Randle equivalent circuit, obtained from EIS data fitting, measured in 0.5 M Na₂SO₃ solution

| Sample | Condition | R _s (Ω) | CPE | | R _{total} =R _{bulk} +R _{ct} (KΩ) | Error(%) |
|--------|--------------|--------------------|-------------------------|-------|--|----------|
| | | | C _{total} (μF) | α | | |
| BVO | Dark | 49.6 | 3.17 | 0.967 | 3.47 | 1.0 |
| | Illumination | 47.2 | 2.30 | 0.956 | 2.89 | 2.0 |
| Mo-BVO | Dark | 45.4 | 3.14 | 0.960 | 2.31 | 1.2 |
| | Illumination | 44.7 | 3.21 | 0.958 | 2.06 | 2.0 |

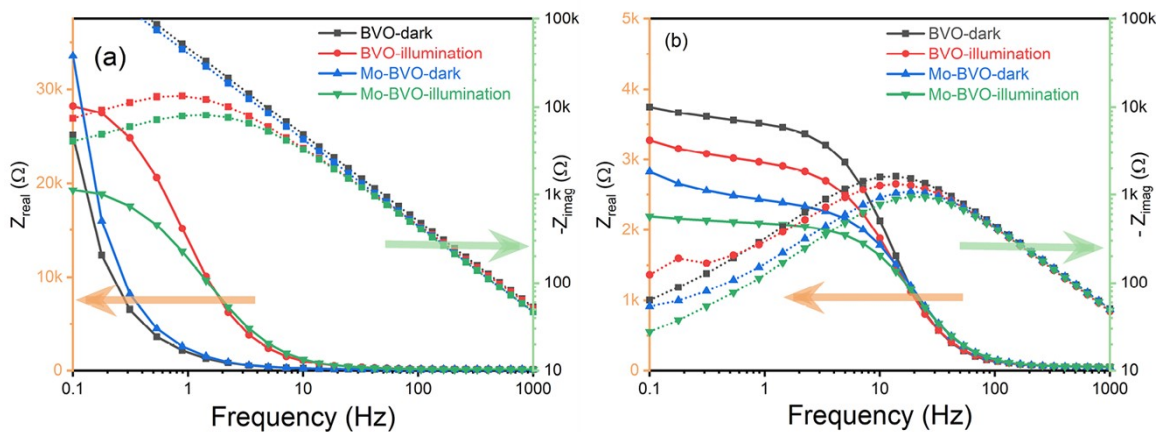


Figure S5 Resistance vs. frequency plots of as-prepared BVO samples, measured at 1.2 V vs. RHE in 0.1 M phosphate buffer solution (a) and 0.5 M Na_2SO_3 solution (b). The real resistance at 1 kHz is independent of frequency and the slope of imaginary resistance at 1 kHz is close to 1, which indicates 1 kHz of frequency is suitable for Mott-Schottky measurement.

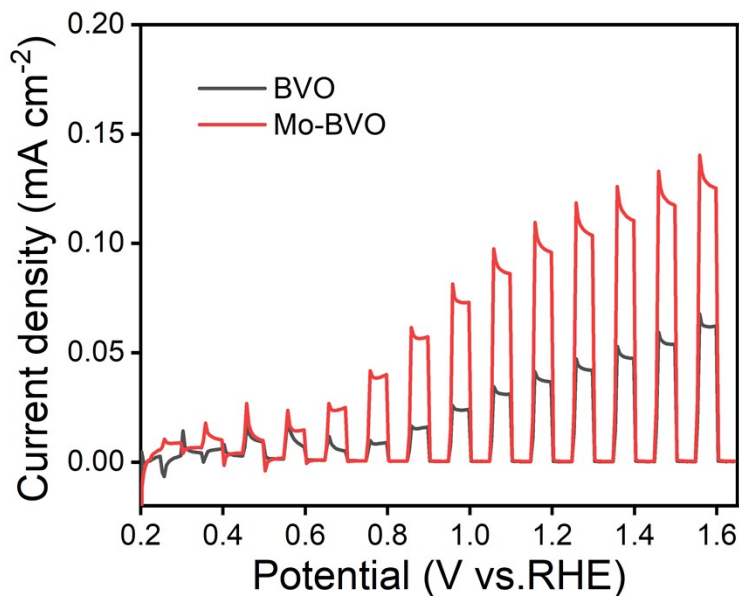


Figure S6 Chopped light voltammetry (CLV) curves of BVO and Mo-BVO samples, measured in 0.1 M phosphate buffer solution. The scan rate is 50 mV s^{-1} .

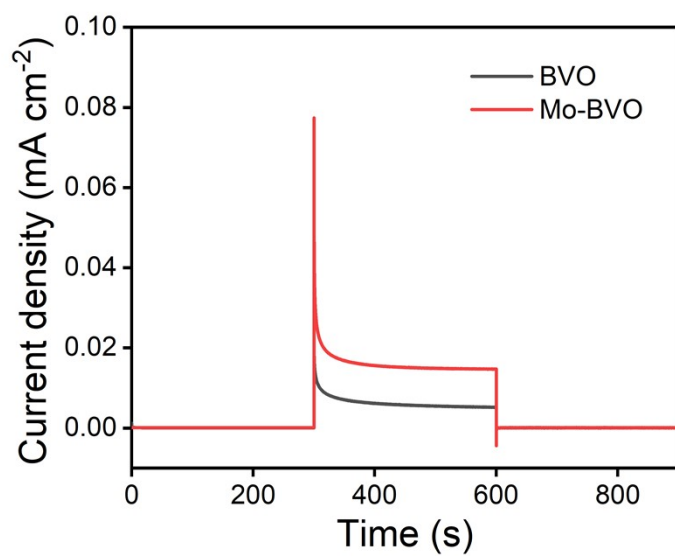


Figure S7 Chopped photocurrent curves of BVO and Mo-BVO samples, measured at 1.2 V_{RHE} in 0.1 M phosphate buffer solution.